

## MSA Tutorials Videos

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The Microscopy Society of America, through its Education Committee, has gathered, produced, and distributed video recordings on microscopy and related topics since 1976. Since 1982, most new acquisitions have been tutorial lectures at MSA Annual Meetings and it is the Society's continuing practice to record all such tutorials for inclusion in the collection. At the same time, MSA continues to augment the Video Library by soliciting relevant titles from a variety of sources. Anyone having, or knowing of, a tape that might be suitable is encouraged to contact the current Chairperson of the Education Committee.

The current catalog is presented below, however, anyone in the future, interested in ordering or purchasing a DVD should refer to the MSA website for the most up to date version of the catalog. (<http://www.msa.microscopy.org/MSAUnits/Education/VideoCatalogue.html>). All titles are now available as DVD only. Many of the videos are old and may be of poor technical quality but often contain good information presented by notable microscopists. Please be aware of this when ordering. You will notice that there are gaps in the numbering of videos. These represent lost or corrupted masters. If anyone has a copy of any of the missing numbers, MSA would appreciate borrowing these so that they may be restored to the collection. The title numbers are not in chronological order.

The tutorial organizers are always open to suggestions for new tutorials or recommendations to update past presentations. If you would be willing to present a tutorial or have suggestions in this regard, you may contact the Chairperson of the Education Committee. ■

### MSA Video Catalog

#	Title/Presenter	Year	Price
#1	<b>The Transmission Electron Microscope 29 minutes/ B&amp;W</b> Presented by Zeiss	1982	\$8.00
#2	<b>Using the LKB Knifemaker 17 minutes/color</b> Presented by Anon.		\$8.00
#3	<b>Mikros Vacuum Evaporator 37 minutes</b> Presented by EM Lab Berkeley		\$8.00
#4	<b>Using the Wescor 5100 Osmometer 13 minutes/color</b> Presented by EM Lab Berkeley		\$8.00
#5	<b>Electron Micrography 12 minutes/ B&amp;W</b> Presented by Gambill		\$8.00
#6	<b>Sectioned Biological Material 16 minutes/color</b> Presented by Anon		\$8.00
#7	<b>The Penetrating Eye 22 minutes/color</b> Presented by Hayes	1970	\$8.00
#8	<b>Introduction to SEM 57 minutes/color</b> Presented by Hayes	1982	\$8.00
#9	<b>Critical Point Drying 22 minute</b> Presented by Humphries	1977	\$8.00
#10	<b>Particulate Sample Preparation 25 minute/color</b> Presented by Berkeley EM Lab		\$8.00
#11	<b>High Resolution Surface Replication 33 minutes/ B&amp;W</b> Presented by Berkeley EM Lab		\$8.00
#14	<b>The Kleinschmidt Technique 22 minute/color</b> Presented by Hebert		\$8.00
#15	<b>Glycol Methacrylate Embedding for Light Microscopy 60 minutes/color</b> Presented by Moe	1980	\$8.00
#16	<b>Interpreting TEM's Three Dimensionally 6 minutes/B&amp;W</b> Presented by Pederson		\$8.00
#17	<b>Introduction to Freeze-Fracture 77 minutes/color</b> Presented by Schooley	1982	\$8.00
#19	<b>Weak-Beam EM 47 Minutes/color</b> Presented by VanderSande	1977	\$8.00
#20	<b>A lecture on Electron Channeling 47 minutes/color</b> Presented by Davidson	1978	\$8.00
#21	<b>Preparation of Macromolecules for TEM 47minutes/color</b> Presented by Slayter		\$8.00
#22	<b>Preparation of Support Films for TEM 14 minutes/color</b> Presented by Pechak	1980	\$8.00
#23	<b>Basic Optics in SEM 40 minutes/ color</b> Presented by Crang	1980	\$8.00
#24	<b>Biological Procedures in EM 41 minutes/ B&amp;W</b> Presented by Crang	1971	\$8.00
#26	<b>Electron Microscopy. Principles and Practice 153 minutes/ B&amp;W</b> Presented by Crang	1975	\$8.00
#27	<b>Operation of the JEOL 100C/CX TEM 75 minutes</b> Presented by Cummings		\$8.00
#28	<b>Stereology 52 minutes/color</b> Presented by Scales	1982	\$8.00
#29	<b>JEOL JSM-35 SEM Part I 36 minutes/color</b> Presented by Thurston		\$8.00
#30	<b>JEOL JMS-35 SEM Part II 35 minutes/color</b> Presented by Thurston	1978	\$8.00
#31	<b>Fine Tuning Your SEM 56 minutes/color</b> Presented by Gaugler	1982	\$8.00
#34	<b>Theory of HVEM II 58 minutes/ B&amp;W</b> Presented by Humphreys	1982	\$8.00
#35	<b>Theory of HVEM III 40 minutes/ B&amp;W</b> Presented by Humphreys	1982	\$8.00
#36	<b>Theory of HVEM IV 57 minutes/ B&amp;W</b> Presented by Humphreys	1982	\$8.00
#37	<b>Kinetic Studies I 57 minutes/ B&amp;W</b> Presented by Loretto	1982	\$8.00
#38	<b>Kinetic Studies II 44 minutes/ B&amp;W</b> Presented by Loretto	1982	\$8.00
#39	<b>Kinetic Studies III 74 minutes/ B&amp;W</b> Presented by Westmacott:		\$8.00
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#42	<b>Radiation Damage III 50 minutes/ B&amp;W</b> Presented by Merkle	1982	\$8.00
#44	<b>Radiation Damage IV 22 minutes/ B&amp;W</b> Presented by King	1982	\$8.00
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#48	<b>Glass &amp; Ceramics; Ion Milling 90 minutes/color</b> Presented by Howitt	1983	\$8.00
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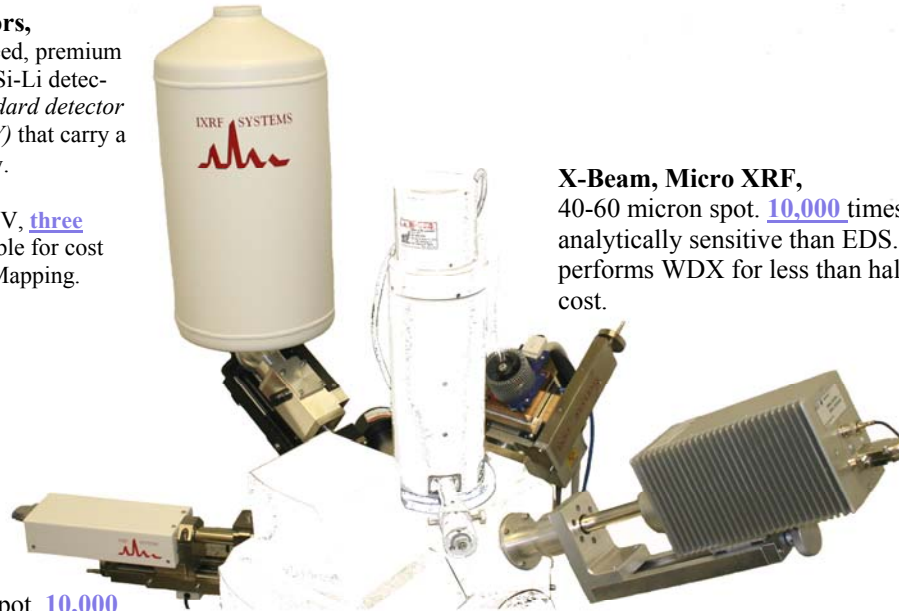
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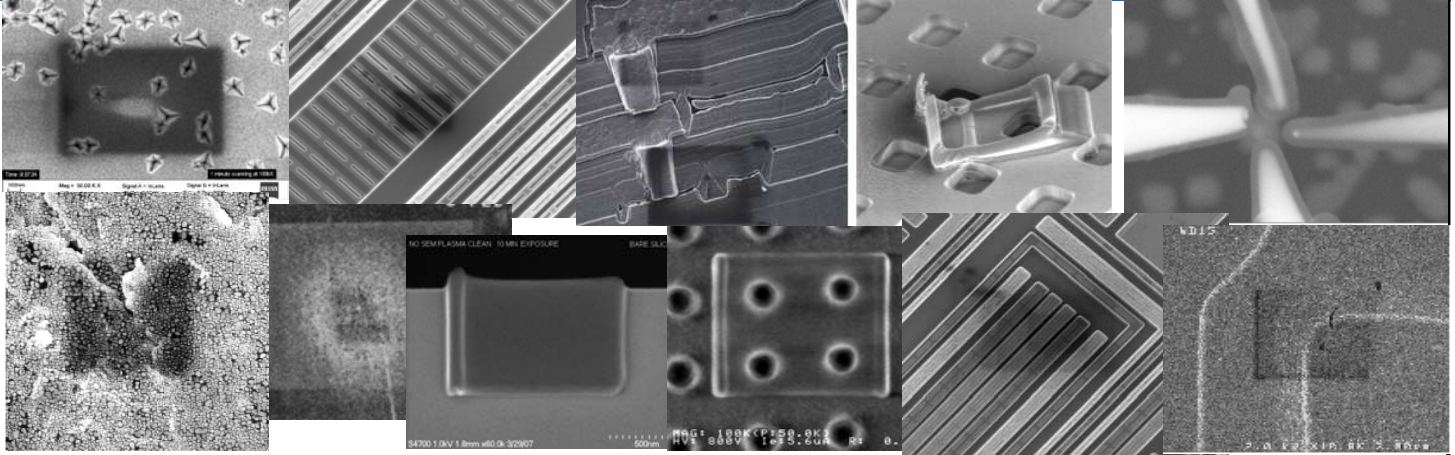
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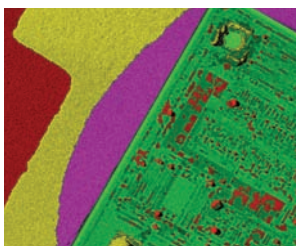
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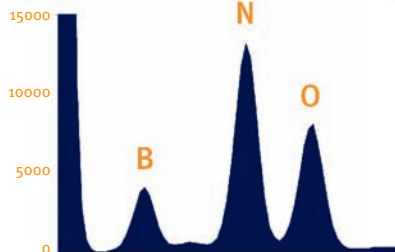
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